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Application/Control No.	Applicant(s)/Patent under Reexamination	r
10/735,290	NAGAI ET AL.	
Examiner	Art Unit	
Michael Y Won	2155	

SEARCHED				
Class	Subclass	Date	Examiner	
709	205, 206, 207	11/28/2007	MW	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
709	206	11/28/2007	MW	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST: USPAT; SUPG-PUB; DERWENT; EPO; JPO	11/28/2007	MW	
NPL SEARCH: IEEE & GOOGLE	11/28/2007	MW	
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